

**DESCRIPTION**

The AM03NS10H is available in a TO-247, TO-220, TO-263-2, TO-263-7 and TOLL-8 packages.

Package	BVDSS	RDS(on)	ID
TO-247			
TO-220	100V	2.7mΩ	180A
TO-263-2			
TO-263-7	100V	2.3mΩ	216A
TOLL-8			

ORDERING INFORMATION

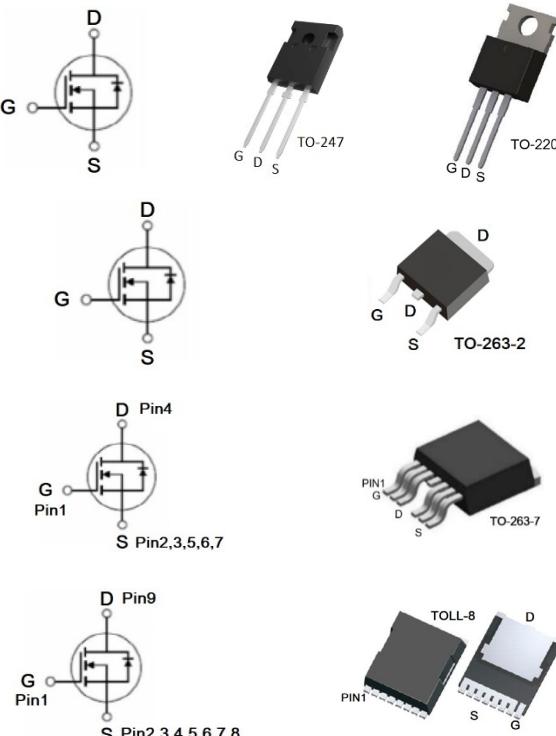
Package Type	Part Number	
TO-247 SPQ: 30pcs/Tube	TL3F	AM03NS10HTL3FU
		AM03NS10HTL3FVU
TO-220 SPQ: 50pcs/Tube	T3	AM03NS10HT3U
		AM03NS10HT3VU
TO-263-2 SPQ: 800pcs/ Reel	S2	AM03NS10HS2R
		AM03NS10HS2VR
TO-263-7 SPQ: 800pcs/ Reel	S7	AM03NS10HS7R
		AM03NS10HS7VR
TOLL-8 SPQ:1,200pcs/Reel	PH8	AM03NS10HPH8R
		AM03NS10HPH8VR
Note	V: Halogen free Package R: Tape & R U: Tube	
AiT provides all RoHS products		

FEATURES

- Fast Switching
- Low On-Resistance
- Low Gate Charge
- Low Reverse transfer capacitances
- High avalanche ruggedness

APPLICATION

- BMS
- High Current Switching Applications

PIN DESCRIPTION

Pin #					Symbol	Functions
TO-247	TO-220	TO-263-2	TO-263-7	TOLL-8		
1	1	1	1	1	G	Gate
2	2	2,4	4	9	D	Drain
3	3	3	2,3,5,6,7	2,3,4,5,6,7,8	S	Source



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ABSOLUTE MAXIMUM RATINGS

at $T_c = 25^\circ\text{C}$, unless otherwise specified

V _{DSS} , Drain-Source Voltage			100V	
I_D	Continuous Drain Current, Silicon Limited	TO-220, TO-263-2	200A	
		TO-247	239A	
		TO-263-7, TOLL-8	216A	
	Continuous Drain Current, Package Limited	TO-220, TO-263-2	180A	
		TO-247		
		TO-263-7, TOLL-8	300A	
	@ $T_c = 100^\circ\text{C}$, Silicon Limited	TO-220, TO-263-2	126.6A	
		TO-247	151.3A	
		TO-263-7, TOLL-8	137A	
I_{DM} , Pulsed Drain Current ⁽¹⁾	TO-220, TO-263-2		720A	
	TO-247			
	TO-263-7, TOLL-8		864A	
V _{GS} , Gate-Source Voltage			±20V	
E _{AS} , Avalanche Energy ⁽²⁾			784mJ	
P_D	Power Dissipation	TO-220, TO-263-2	250W	
		TO-263-7, TOLL-8		
	TO-247		357W	
	Derating Factor above 25°C	TO-220, TO-263-2	2W/°C	
		TO-263-7, TOLL-8		
		TO-247	2.85W/°C	
T_J , Operating Junction Temperature Range			150°C	
T_{STG} , Storage Temperature Range			-55°C~150°C	
T_L , Maximum Temperature for Soldering			260°C	

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Repetitive Rating : Pulse width limited by maximum junction temperature.

(2) L=0.5mH, I_{AS}=56A, Start $T_J = 25^\circ\text{C}$



ELECTRICAL CHARACTERISTICS

at $T_C = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Min	Typ.	Max	Units	
OFF Characteristics							
Drain-Source Breakdown Voltage	V_{DSS}	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$,	100	110	-	V	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$	-	-	1	μA	
		$V_{DS}=80\text{V}, V_{GS}=0\text{V}, @ T_C=125^\circ\text{C}$	-	-	100	μA	
Gate-Source Forward Leakage	$I_{GSS(F)}$	$V_{GS}=+20\text{V}$	-	-	100	nA	
Gate-Source Reverse Leakage	$I_{GSS(R)}$	$V_{GS}=-20\text{V}$	-	-	-100	nA	
ON Characteristics							
Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10\text{V}, I_D=50\text{A}$.	TO-220	-	2.7	3.0	$\text{m}\Omega$
			TO-263-2	-	2.3	3.0	
TO-247			TO-263-7	-	2.3	3.0	
TO-263-7			TOLL-8				
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2	3	4	V	
Pulse width $t_p \leq 300\mu\text{s}, \delta \leq 2\%$							
Dynamic Characteristics							
Input Capacitance	C_{iss}	$V_{DS}=50\text{V}, V_{GS}=0, f=1\text{MHz}$	-	9200	-	pF	
Output Capacitance	C_{oss}		-	1130	-		
Reverse Transfer Capacitance	C_{rss}		-	110	-		
Total Gate Charge	Q_g	$V_{DD}=50\text{V}, I_D=92.5\text{A}, V_{GS}=10\text{V}$	-	131	-	nC	
Gate-Source charge	Q_{gs}		-	50	-		
Gate-Drain charge	Q_{gd}		-	24.5	-		
Switching Characteristics							
Turn-On Delay Time	$t_d(\text{ON})$	$V_{DD}=50\text{V}, I_D=10\text{A}, V_{GS}=10\text{V}, R_G = 1.6\Omega$ Resistive Load	-	32	-	ns	
Rise Time	t_r		-	40	-		
Turn-Off Delay Time	$t_d(\text{OFF})$		-	80	-		
Fall Time	t_f		-	35	-		



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Parameter	Symbol	Conditions	Min	Typ.	Max	Units
Source-Drain Diode Characteristics						
Continuous Source Current	Is		TO-220	-	-	180
			TO-263-2	-	-	A
Maximum Pulsed Current	IsM		TO-247	-	-	216
			TO-263-7	-	-	
Diode Forward Voltage	VSD	V _{GS} =0V, Is=50A	TO-220	-	-	720
			TO-263-2	-	-	A
Reverse Recovery Time	Tr _{rr}	Is=92.5A, V _{GS} =0, di/dt=100A/us	TO-247	-	-	864
			TO-263-7	-	-	
Reverse Recovery Charge	Q _{rr}	di/dt=100A/us	TOLL-8	-	-	nC
			-	195	-	

THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Units
Thermal resistance, Junction-Ambient	R _{θJA}	62.5	°C/W
Thermal resistance, Junction-Case	R _{θJC}	0.50	°C/W
		0.35	



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TYPICAL PERFORMANCE CHARACTERISTICS

Fig.1 Safe Operating Area (TO-263-7, TOLL-8)

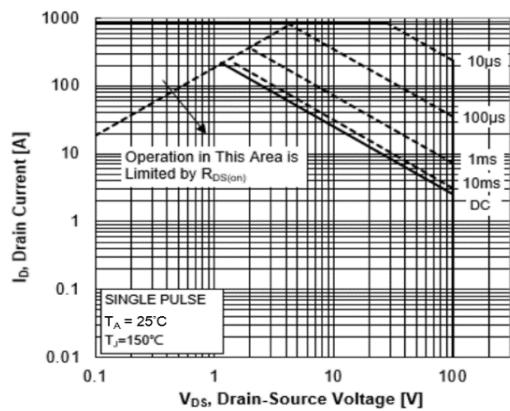


Fig.2 Safe Operating Area (TO-247)

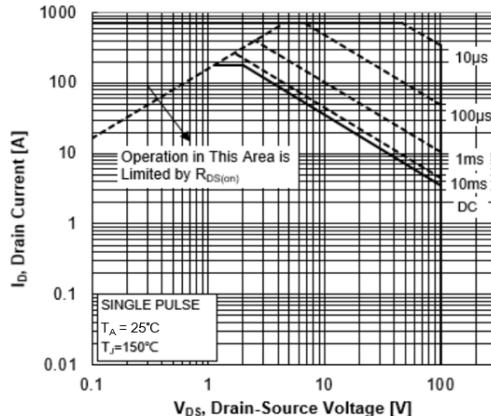


Fig.3 Safe Operating Area (TO-263-2, TO-220)

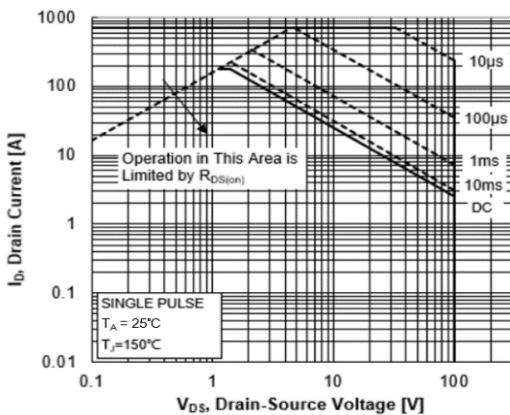


Fig.4 Maximum Power Dissipation vs. Case Temperature (TO-263-7, TOLL-8, TO-263-2, TO-220)

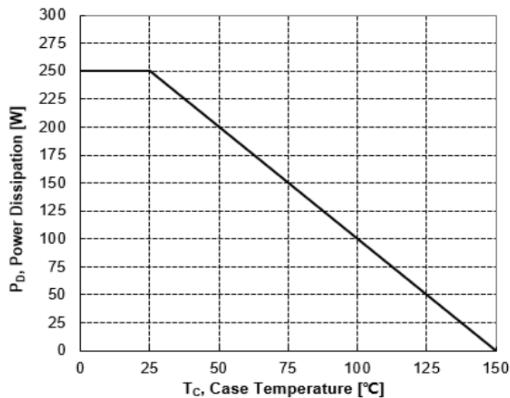


Fig.5 Maximum Power Dissipation vs. Case Temperature (TO-247)

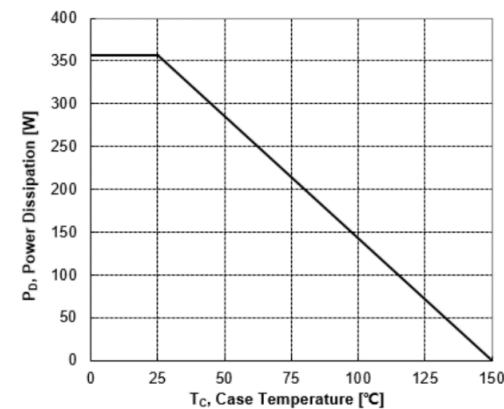
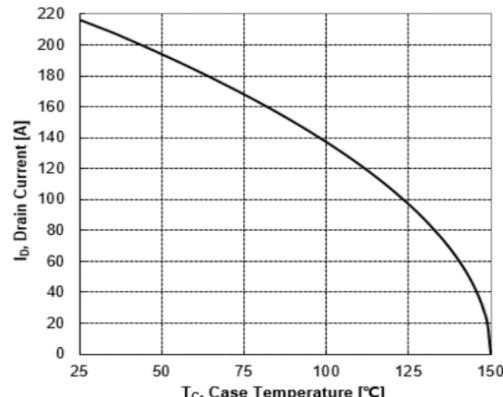


Fig.6 Maximum Continuous Drain Current vs. Case Temperature (TO-263-7, TOLL-8)





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Fig.7 Maximum Continuous Drain Current vs. Case Temperature (TO-247)

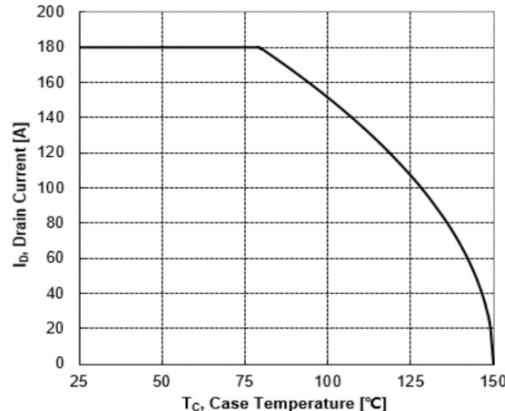


Fig.9 Typical Output Characteristics

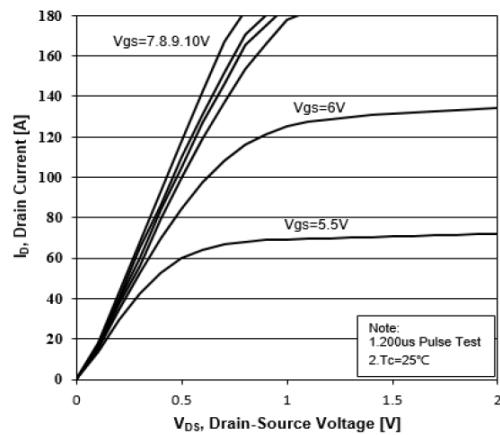


Fig.11 Source-Drain Diode Forward Characteristics

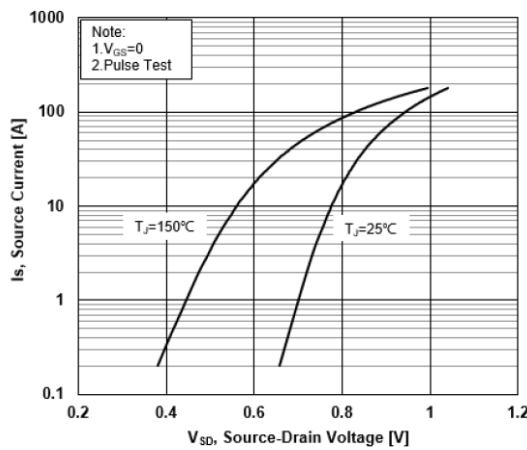


Fig.8 Maximum Continuous Drain Current vs. Case Temperature (TO-263-2, TO-220)

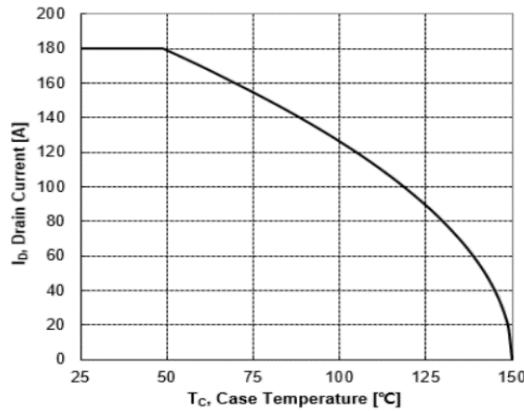


Fig.10 Typical Transfer Characteristics

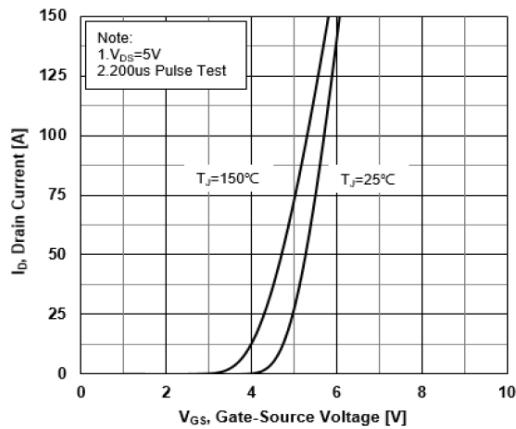
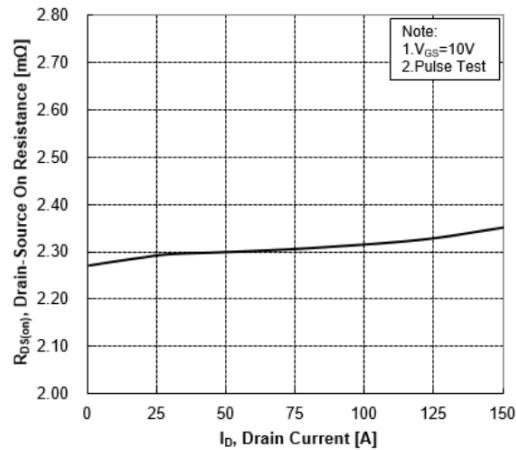


Fig.12 Drain-Source On-Resistance vs. Drain Current (TO-263-7, TOLL-8)





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Fig.13 Drain-Source On-Resistance vs. Drain Current (TO-247, TO-263-2, TO-220)

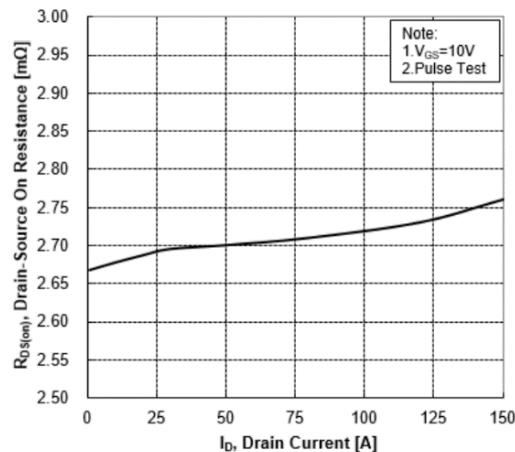


Fig.15 Normalized Threshold Voltage vs. Junction Temperature

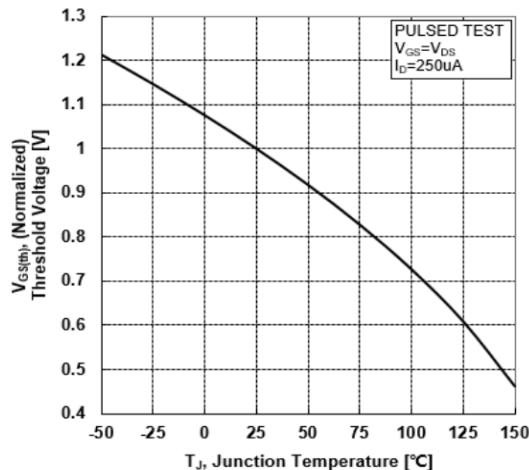


Fig.17 Capacitance Characteristics

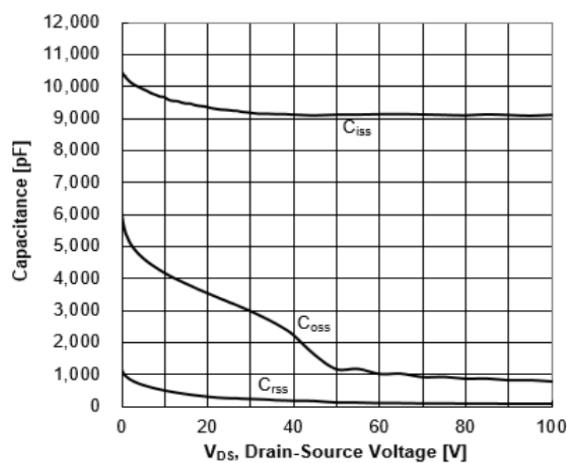


Fig.14 Normalized On-Resistance vs. Junction Temperature

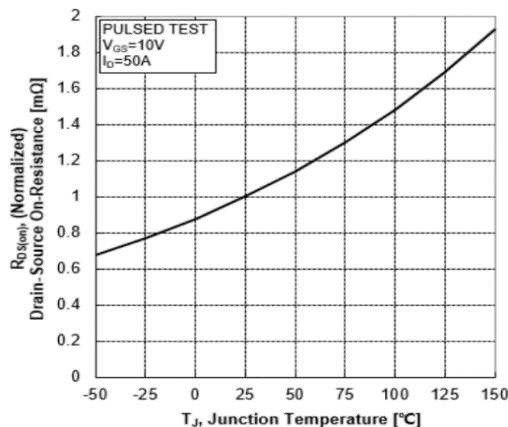


Fig.16 Normalized Breakdown Voltage vs. Junction Temperature

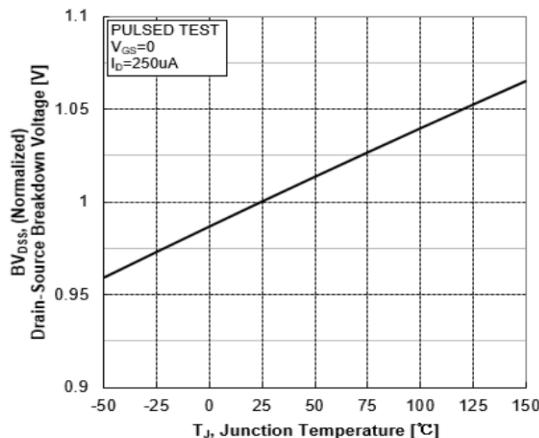
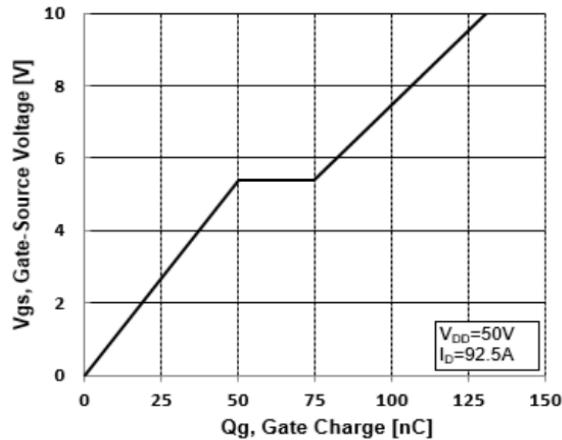


Fig.18 Typical Gate Charge vs. Gate-Source Voltage





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Fig.19 Transient Thermal Impedance (TO-263-7, TOLL-8, TO-263-2, TO-220)

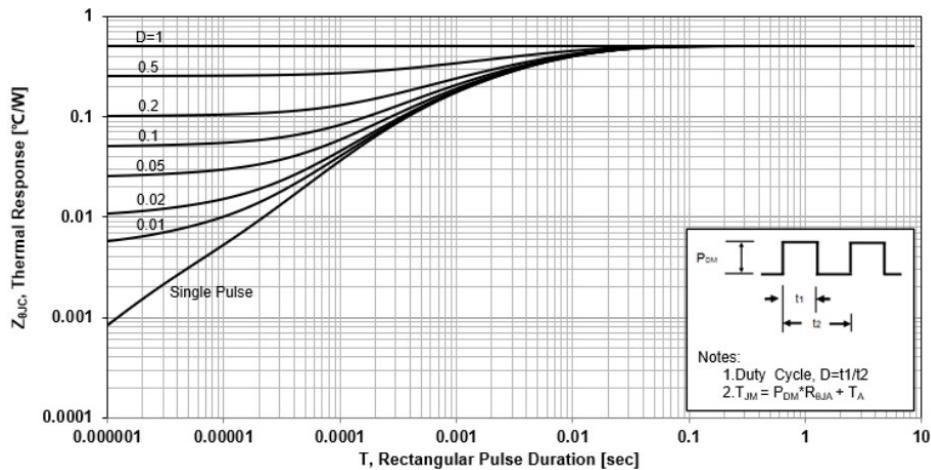


Fig.20 Transient Thermal Impedance (TO-247)

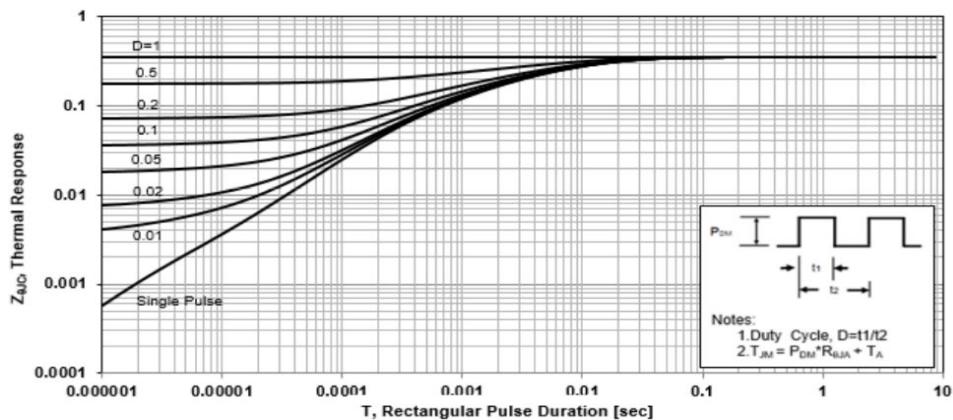


Fig.21 Resistive Switching Test Circuit

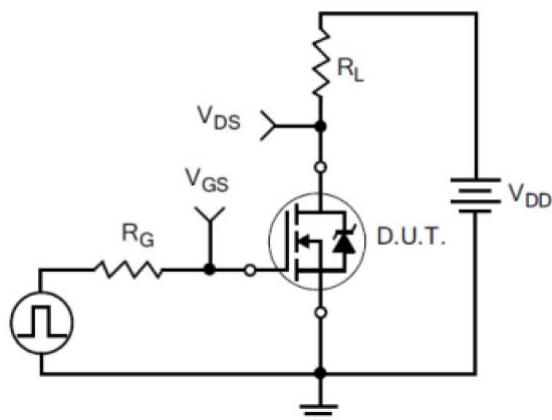
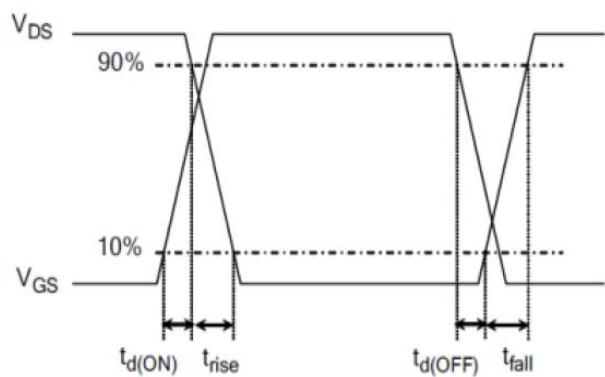


Fig.22 Resistive Switching Waveforms





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Fig.23 Gate Charge Test Circuit

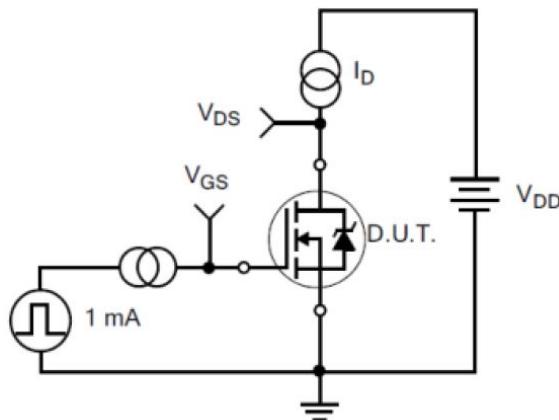


Fig.24 Gate Charge Waveforms

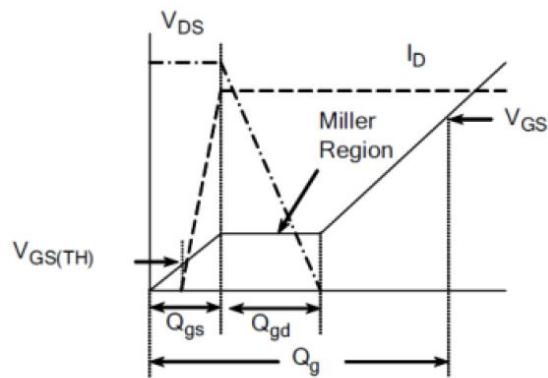


Fig.25 Diode Reverse Recovery Test Circuit

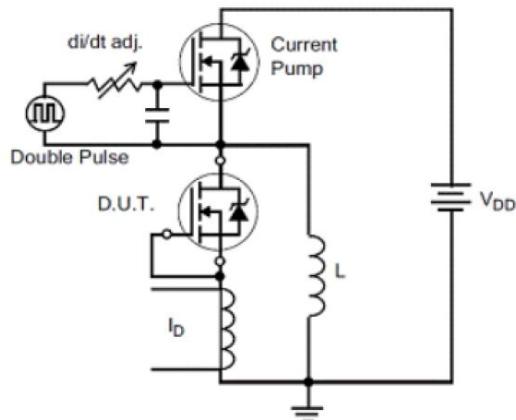


Fig.26 Diode Reverse Recovery Waveforms

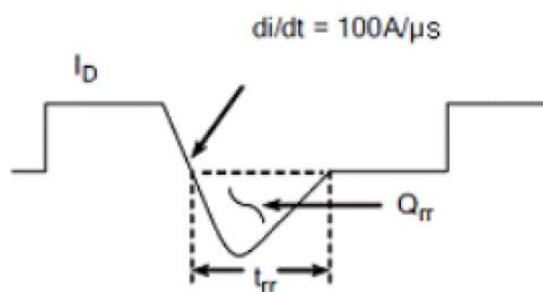


Fig.27 Unclamped Inductive Switching Test Circuit

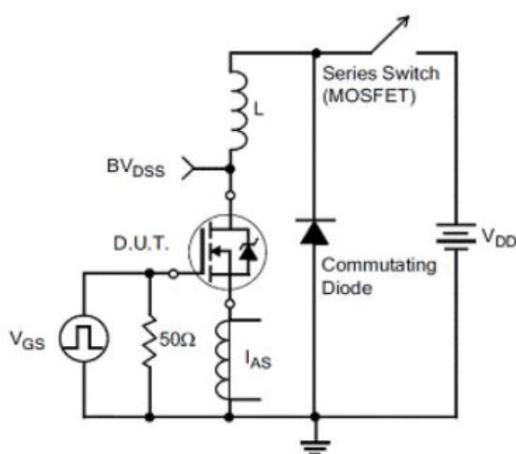
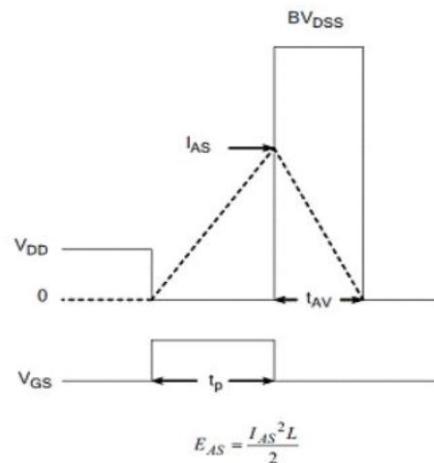


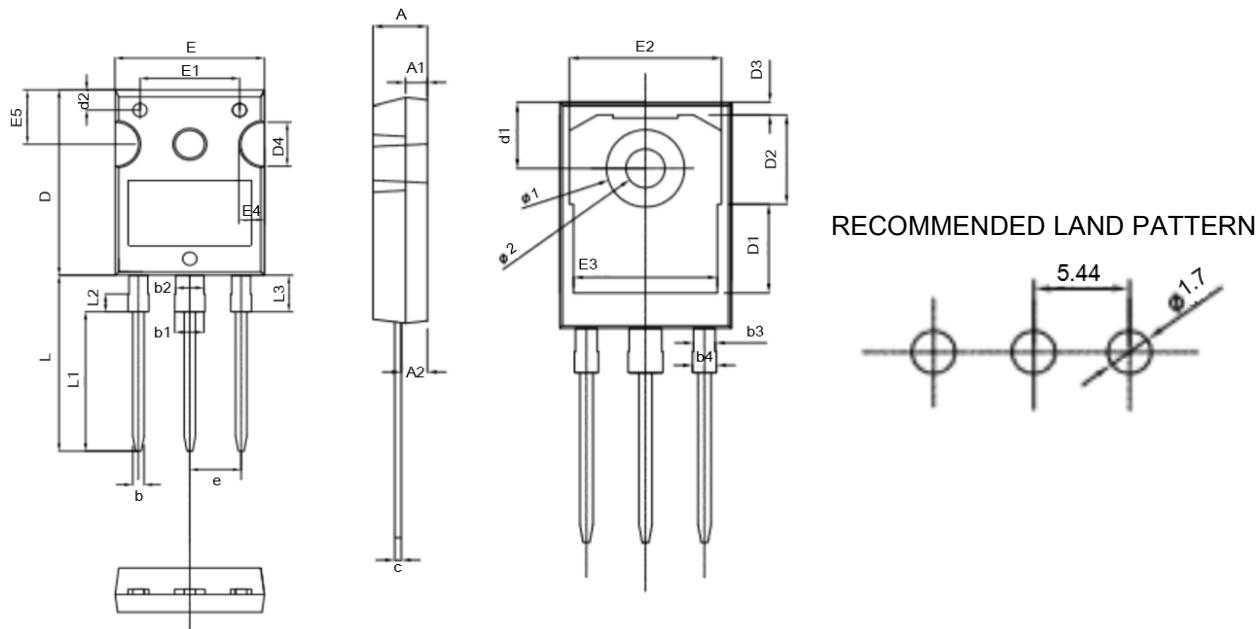
Fig.28 Unclamped Inductive Switching Waveform





PACKAGE INFORMATION

Dimension in TO-247 (Unit: mm)



Symbol	Min.	Max.	Symbol	Min.	Max.
A	4.850	5.150	d2	2.200	2.400
A1	1.900	2.100	E	15.700	16.000
A2	2.270	2.540	E1	10.500	
b	1.100	1.300	E2	14.020	
b1	2.900	3.200	E3	13.500	
b2	2.900	3.100	E4	2.200	2.600
b3	1.900	2.100	E5	5.490	6.000
b4	2.000	2.200	e	5.340	5.540
c	0.550	0.680	L	19.720	20.120
D	20.800	21.100	L1	15.790	
D1	8.230		L2	1.980	
D2	8.320		L3	4.000	4.470
D3	1.170		Ø1	7.100	7.300
D4	3.680	5.100	Ø2	3.500	3.700
d1	6.040	6.300			



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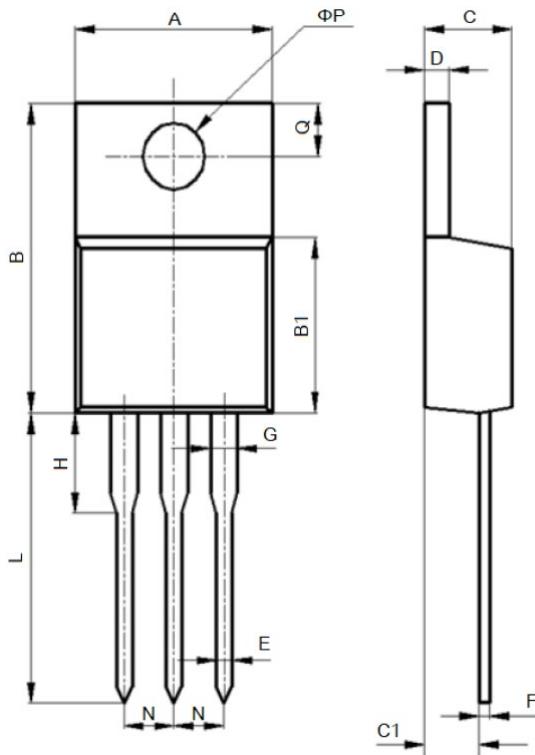
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Dimension in TO-220 (Unit: mm)



Symbol	Min.	Max.
A	9.600	10.600
B	15.000	16.000
B1	8.900	9.500
C	4.300	4.800
C1	2.300	3.100
D	1.200	1.400
E	0.700	0.900
F	0.300	0.600
G	1.170	1.370
H	2.700	3.800
L	12.600	14.800
N	2.340	2.740
Q	2.400	3.000
ΦP	3.500	3.900



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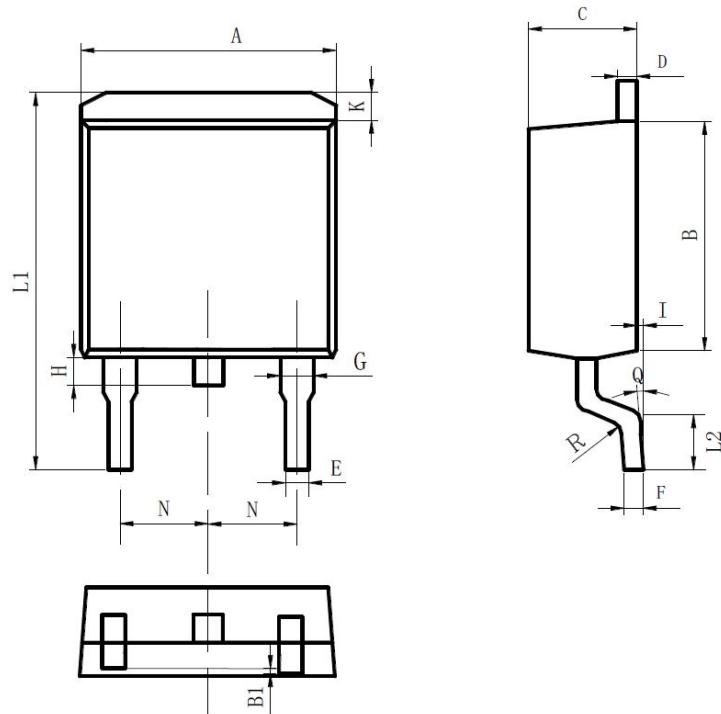
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Dimension in TO-263-2 (Unit: mm)



Symbol	Min.	Max.
A	9.800	10.400
B	8.900	9.500
B1	0.000	0.100
C	4.400	4.800
D	1.160	1.370
E	0.700	0.950
F	0.300	0.600
G	1.070	1.470
H	1.300	1.800
K	0.950	1.370
L1	14.500	16.500
L2	1.600	2.300
I	0.000	0.200
Q	0°	8°
R	0.400	0.400
N	2.390	2.690



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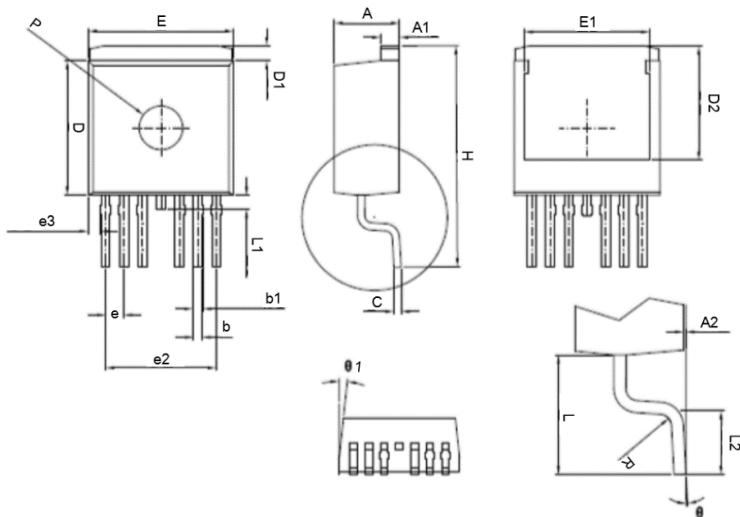
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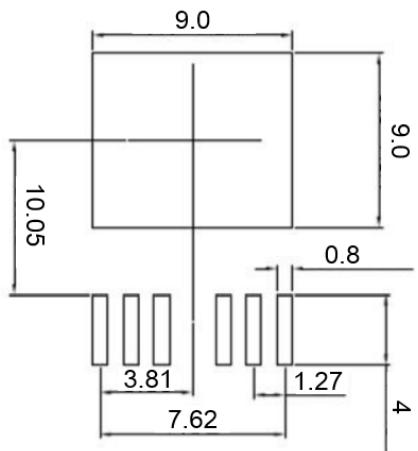
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Dimension in TO-263-7 (Unit: mm)



RECOMMENDED LAND PATTERN



Symbol	Min.	Max.
A	4.300	4.700
A1	1.200	1.400
A2	0.050	0.300
b	0.500	0.700
b1	0.500	0.900
c	0.400	0.600
D	9.050	9.450
D1	0.700	1.300
D2	7.350	8.350
E	9.800	10.200
E1	8.100	9.100
e	1.070	1.470
e2	7.320	7.920
e3	0.640	1.040
H	14.650	15.650
L	4.470	5.470
L1	0.900	1.500
L2	2.200	2.800
θ	0°	8°
θ_1	0°	10°
Φ_P	2.700	3.300



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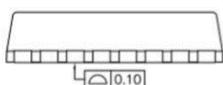
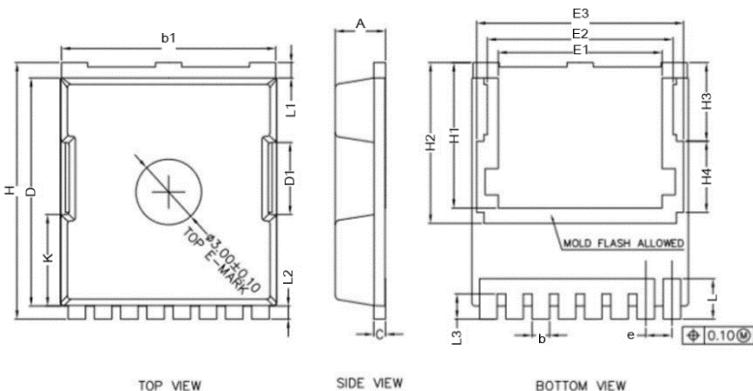
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Dimension in TOLL-8 (Unit: mm)



SIDE VIEW

Symbol	Min.	Max.
A	2.200	2.400
b	0.700	0.900
b1	9.700	9.900
c	0.400	0.600
D	10.280	10.580
D1	3.150	3.450
E	9.700	10.100
E1	7.350	7.650
E2	8.350	8.650
E3	9.310	9.610
e	1.100	1.300
H	11.480	11.880
H1	6.550	6.750
H2	7.200	7.500
H3	3.440	3.740
H4	3.110	3.410
K	4.030	4.330
L	1.600	2.100
L1	0.550	0.850
L2	0.450	0.750
L3	1.000	1.300



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